



BEAS-01161050

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	Examiner Chih-Ching Chow	Art Unit 2192	Page 1 of 1

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	W	Action Item: <u>Suppl. Info. Discl. Stmt</u> Date Due: <u>January 19, 2006</u> Critical: <u>June 19, 2006</u>			
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U.S. Patent and Trademark Office
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/Tuyetlien Tran/

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	Examiner TuyetLien (Lien) T. Tran	Art Unit 2179	Page 1 of 2

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